Applicant(s)/Patent Under Reexamination Application/Control No. 10/705,222 SEGAWA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Dung Nguyen 2871 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,805,246	09-1998	Lee et al.	349/40
*	В	US-6,190,934	02-2001	Kang et al.	438/30
	С	US-			
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	Ε	US-			
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	G	US-			
	Н	US-			
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	. W	US- "			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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